

### **Description**

The VSM4P06 uses advanced trench technology and design to provide excellent  $R_{\text{DS(ON)}}$  with low gate charge .This device is well suited for use as a load switch or in PWM applications.

#### **General Features**

V<sub>DS</sub> =-60V,I<sub>D</sub> =-4.3A

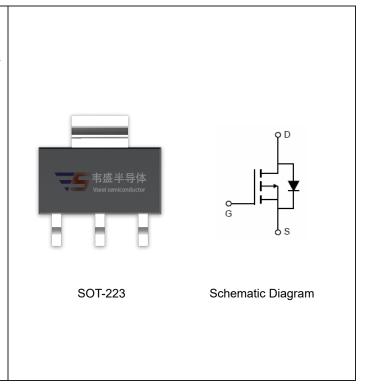
 $R_{DS(ON)}$  <120m $\Omega$  @  $V_{GS}$ =-10V

 $R_{DS(ON)}$  <170m $\Omega$  @  $V_{GS}$ =-4.5V

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation

#### **Application**

- Load switch
- PWM application



### **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM4P06-S23	VSM4P06	SOT-223	Ø330mm	12mm	2500 units

### Absolute Maximum Ratings (T<sub>C</sub>=25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	-60	V
Gate-Source Voltage	V <sub>G</sub> s	±20	V
Drain Current-Continuous	I <sub>D</sub>	-4.3	А
Pulsed Drain Current	I <sub>DM</sub>	-20	Α
Maximum Power Dissipation	P <sub>D</sub>	3.1	W
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	$^{\circ}$ C

#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient <sup>(Note 2)</sup>	$R_{ hetaJA}$	40.3	°C/W

### **Electrical Characteristics (T<sub>C</sub>=25**°C unless otherwise noted)

Parameter Symbol Condition		Min	Тур	Max	Unit	
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-60	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-60V,V <sub>GS</sub> =0V	-	_	-1	μA

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Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ =±20 $V$ , $V_{DS}$ =0 $V$	-	-	±100	nA	
On Characteristics (Note 3)							
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}$ = $V_{GS}$ , $I_D$ =-250 $\mu$ A	-1.0		-2.5	V	
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	$V_{GS}$ =-10V, $I_D$ =-4A	-	106	120	mΩ	
Diani-Source On-State Resistance	NDS(ON)	$V_{GS}$ =-4.5V, $I_D$ =-3A	-	135	170	mΩ	
Forward Transconductance	<b>g</b> FS	$V_{DS}$ =-5 $V$ , $I_{D}$ =-4 $A$	-	10	-	S	
Dynamic Characteristics (Note4)							
Input Capacitance	C <sub>lss</sub>	\/ - 20\/\/ -0\/	-	930	-	PF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =-30V, $V_{GS}$ =0V, F=1.0MHz	-	85	-	PF	
Reverse Transfer Capacitance	C <sub>rss</sub>	r-1.0ivinz	-	35	-	PF	
Switching Characteristics (Note 4)							
Turn-on Delay Time	t <sub>d(on)</sub>		-	8	-	nS	
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =-30V, $R_L$ =7.5 $\Omega$ ,	-	4	-	nS	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =-10 $V$ , $R_{G}$ =3 $\Omega$	-	32	-	nS	
Turn-Off Fall Time	t <sub>f</sub>		-	7	-	nS	
Total Gate Charge	Qg	V - 20 I - 4A	-	25	-	nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =-30,I <sub>D</sub> =-4A, V <sub>GS</sub> =-10V	-	3	-	nC	
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> 10V	-	7	-	nC	
Drain-Source Diode Characteristics							
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-4A	-		-1.2	V	
Diode Forward Current (Note 2)	Is		-	-	-4.3	Α	
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25^{\circ}C, I_F = -4A$	-	25		nS	
Reverse Recovery Charge	Qrr	$di/dt = -100A/\mu s^{(Note3)}$	-	31		nC	

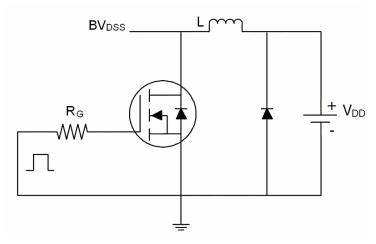
### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2%.
- 4. Guaranteed by design, not subject to production

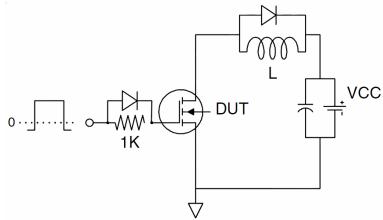


## **Test Circuit**

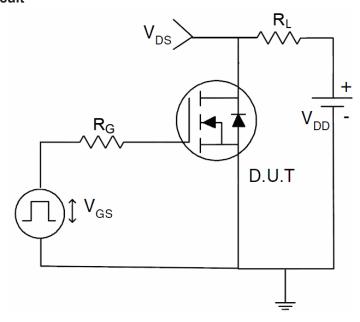
## 1) E<sub>AS</sub> test Circuit



## 2) Gate charge test Circuit

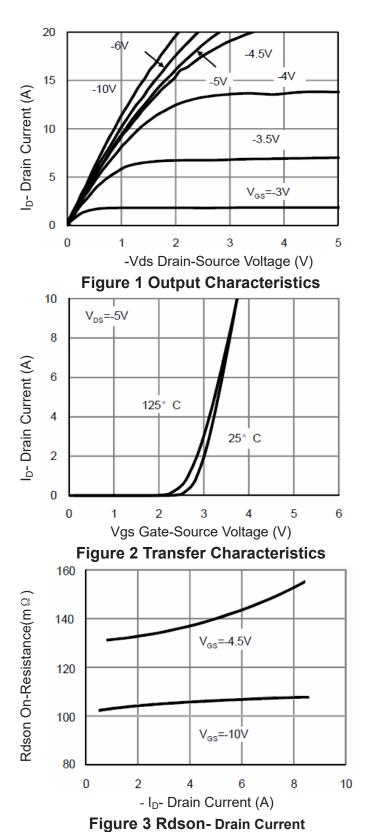


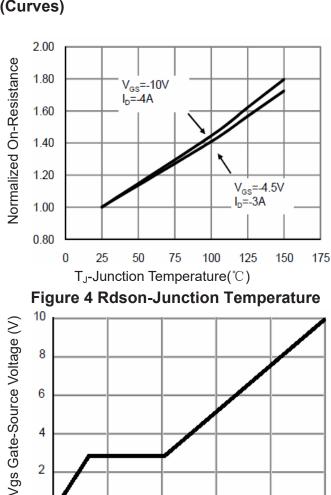
# 3) Switch Time Test Circuit

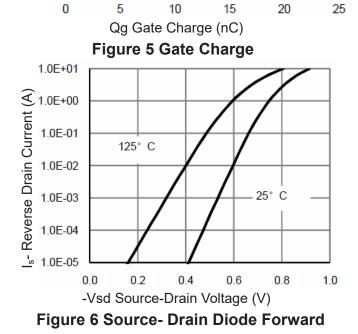




### Typical Electrical and Thermal Characteristics (Curves)

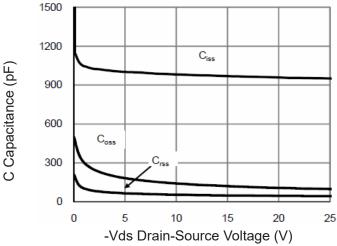






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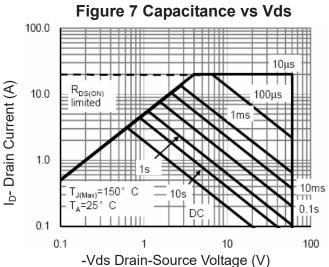


Figure 8 Safe Operation Area

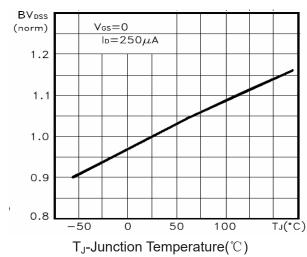


Figure 9 BV<sub>DSS</sub> vs Junction Temperature

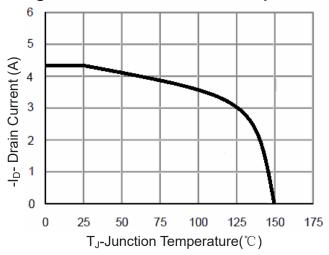


Figure 10 ID Current De-rating

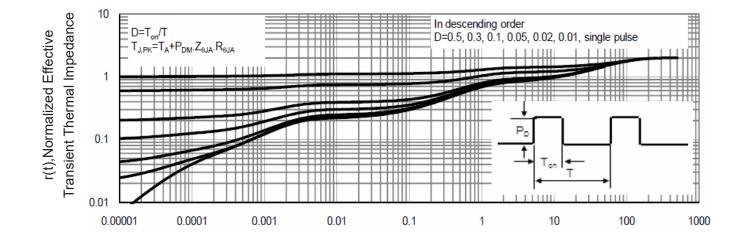
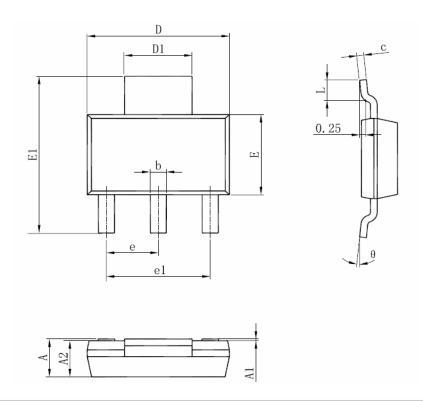


Figure 11 Normalized Maximum Transient Thermal Impedance

Square Wave Pluse Duration(sec)



## **SOT-223 Package Information**



Comb a l	Dimensions Ir	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	1.520	1.800	0.060	0.071	
A1	0.000	0.100	0.000	0.004	
A2	1.500	1.700	0.059	0.067	
b	0.660	0.820	0.026	0.032	
С	0.250	0.350	0.010	0.014	
D	6.200	6.400	0.244	0.252	
D1	2.900	3.100	0.114	0.122	
E	3.300	3.700	0.130	0.146	
E1	6.830	7.070	0.269	0.278	
е	2.300	(BSC)	0.091(	BSC)	
e1	4.500	4.700	0.177	0.185	
L	0.900	1.150	0.035	0.045	
θ	0°	10°	0°	10°	

#### **Notes**

- 1. All dimensions are in millimeters.
- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.
- 5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.